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Application/Control No.	Applicant(s)/Patent under Reexamination
09/994,620	HAYASHI ET AL.
Examiner	Art Unit
Saeid Ebrahimi-dehKordy	2626

	SEARCHED		
Class	Subclass	Date	Examiner
358	1.15,1.18	8/16/2005	SE
358	1.16,1.13	8/16/2005	SE
347	19,40,37	8/17/2005	SE
235	492	8/17/2005	SE
399	27	8/17/2005	SE
379	428,433	8/18/2005	SE
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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	DATE	EXMR
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